## **EXAS** INSTRUMENTS

Data sheet acquired from Harris Semiconductor SCHS259 NOT RECOMMENDED

January 1997

## Buffered Inputs

Features

• Typical Propagation Delay: 5.6ns at V<sub>CC</sub> = 5V, T<sub>∆</sub> = 25<sup>o</sup>C

FOR NEW DESIGNS Use CMOS Technology

- Positive Edge Triggered
- CD74FCT564 - Inverting
- CD74FCT574
  - Noninverting
- SCR Latchup Resistant BiCMOS Process and **Circuit Design**
- Speed of Bipolar FAST™/AS/S
- 48mA Output Sink Current
- Output Voltage Swing Limited to 3.7V at V<sub>CC</sub> = 5V
- Controlled Output Edge Rates
- Input/Output Isolation to V<sub>CC</sub>
- · BiCMOS Technology with Low Quiescent Power

# CD74FCT564, **CD74FCT574**

## **BiCMOS FCT Interface Logic**, Octal D-Type Flip-Flops, Three-State

## Description

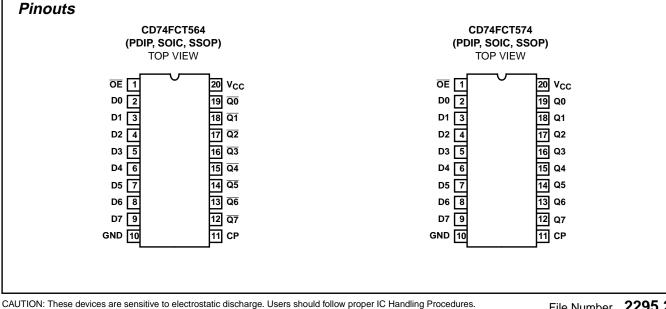
The CD74FCT564 and CD74FCT574 are octal D-Type, three-state, positive edge triggered flip-flops which use a small geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output HIGH level to two diode drops below V<sub>CC</sub>. This resultant lowering of output swing (0V to 3.7V) reduces power bus ringing (a source of EMI) and minimizes V<sub>CC</sub> bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 milliamperes.

The eight flip-flops enter data into their registers on the LOW to HIGH transition of the clock (CP). The Output Enable  $(\overline{OE})$ controls the three state outputs and is independent of the register operation. When the Output Enable ( $\overline{OE}$ ) is HIGH, the outputs are in the high impedance state. The CD74FCT564 and CD74FCT574 share the same configurations; the CD74FCT564, however, has inverted outputs and the CD74FCT574 has noninverted outputs.

### Ordering Information

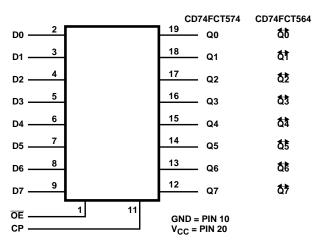
| PART NUMBER  | TEMP.<br>RANGE ( <sup>o</sup> C) | PACKAGE    | PKG.<br>NO. |
|--------------|----------------------------------|------------|-------------|
| CD74FCT564E  | 0 to 70                          | 20 Ld PDIP | E20.3       |
| CD74FCT574E  | 0 to 70                          | 20 Ld PDIP | E20.3       |
| CD74FCT564M  | 0 to 70                          | 20 Ld SOIC | M20.3       |
| CD74FCT574M  | 0 to 70                          | 20 Ld SOIC | M20.3       |
| CD74FCT574SM | 0 to 70                          | 20 Ld SSOP | M20.209     |

NOTE: When ordering the suffix M and SM packages, use the entire part number. Add the suffix 96 to obtain the variant in the tape and reel.



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## Functional Diagram



#### TRUTH TABLE (NOTE 1)

|    |        |    | OUTPUTS    |            |  |  |  |
|----|--------|----|------------|------------|--|--|--|
|    | INPUTS |    | CD74FCT564 | CD74FCT574 |  |  |  |
| ŌĒ | СР     | DN | QN         | QN         |  |  |  |
| L  | Ŷ      | Н  | L          | Н          |  |  |  |
| L  | Ŷ      | L  | Н          | L          |  |  |  |
| L  | L      | Х  | Qo         | Qo         |  |  |  |
| н  | Х      | х  | Z          | Z          |  |  |  |

NOTE:

1. H = High Level (Steady State)

L = Low Level (Steady State)

X = Don't Care

 $\uparrow$  = Transition from low to high level

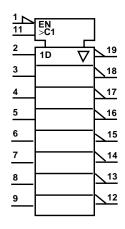
Qo = The level of Q before the indicated steady state input

conditions were established.

Z = HIGH Impedance

## IEC Logic Symbols

#### CD74FCT564



#### CD74FCT574

| 1<br>11 | EN<br>>C1 |        |
|---------|-----------|--------|
| 2       | 1D        | <br>19 |
| 3       |           | <br>18 |
| 4       |           | <br>17 |
| 5       |           | <br>16 |
| 6       |           | <br>15 |
| 7       |           | <br>14 |
| 8       |           | <br>13 |
| 9       |           | <br>12 |
|         |           |        |

#### **Absolute Maximum Ratings**

| DC Supply Voltage (V <sub>CC</sub> )                                      |
|---|
| DC Diode Current, I <sub>IK</sub> (For V <sub>I</sub> < -0.5V)            |
| DC Output Diode Current, I <sub>OK</sub> (for V <sub>O</sub> < -0.5V)50mA |
| DC Output Sink Current per Output Pin, IO                                 |
| DC Output Source Current per Output Pin, IO                               |
| DC V <sub>CC</sub> Current (I <sub>CC</sub> )140mA                        |
| DC Ground Current (I <sub>GND</sub> )400mA                                |

#### **Operating Conditions**

| Operating Temperature Range, T <sub>A</sub> | 0 <sup>0</sup> C to 70 <sup>0</sup> C |
|---|---------------------------------------|
| Supply Voltage Range, V <sub>CC</sub>       | .4.75V to 5.25V                       |
| DC Input Voltage, V <sub>1</sub>            | 0 to V <sub>CC</sub>                  |
| DC Output Voltage, V <sub>O</sub>           | $\dots$ 0 to $\leq$ V <sub>CC</sub>   |
| Input Rise and Fall Slew Rate, dt/dv        | 0 to 10ns/V                           |

#### **Thermal Information**

| Thermal Resistance (Typical, Note 2)                                       | $\theta_{JA}$ ( <sup>o</sup> C/W)      |
|--|--|
| PDIP Package   | 135                                    |
| SOIC Package   | 125                                    |
| SSOP Package   | 130                                    |
| Maximum Junction Temperature   |  |
| Maximum Storage Temperature Range65  | 5 <sup>o</sup> C to 150 <sup>o</sup> C |
| Maximum Lead Temperature (Soldering 10s)<br>(SOIC and SSOP-Lead Tips Only) | 300 <sup>0</sup> C                     |

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

2.  $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.

#### Electrical Specifications Temperature Range $0^{\circ}$ C to $70^{\circ}$ C, V<sub>CC</sub> Max = 5.25V, V<sub>CC</sub> Min = 4.75V

|  |                  |  |                     |                     | AMBIENT TEMPERATURE (T <sub>A</sub> ) |                   |     |             |       |
|--|------------------|--|---------------------|---------------------|---------------------------------------|-------------------|-----|-------------|-------|
|  |                  | TEST CONDITIONS                                  |                     |                     |                                       | 25 <sup>0</sup> C |     | 0°C TO 70°C |       |
| PARAMETER  | SYMBOL           | V <sub>I</sub> (V)                               | I <sub>O</sub> (mA) | V <sub>CC</sub> (V) | MIN                                   | MAX               | MIN | MAX         | UNITS |
| High Level Input Voltage   | V <sub>IH</sub>  |  |                     | 4.5 to 5.5          | 2                                     | -                 | 2   | -           | V     |
| Low Level Input Voltage  | VIL              |  |                     | 4.5 to 5.5          | -                                     | 0.8               | -   | 0.8         | V     |
| High Level Output Voltage  | V <sub>OH</sub>  | V <sub>IH</sub> or<br>V <sub>IL</sub>            | -15                 | Min                 | 2.4                                   | -                 | 2.4 | -           | V     |
| Low Level Output Voltage   | V <sub>OL</sub>  | V <sub>IH</sub> or<br>V <sub>IL</sub>            | 48                  | Min                 | -                                     | 0.55              | -   | 0.55        | V     |
| High Level Input Current   | IIH              | V <sub>CC</sub>                                  |                     | Max                 | -                                     | 0.1               | -   | 1           | μΑ    |
| Low Level Input Current  | IIL              | GND  |                     | Max                 | -                                     | -0.1              | -   | -1          | μΑ    |
| Three-State Leakage Current  | I <sub>OZH</sub> | V <sub>CC</sub>                                  |                     | Max                 | -                                     | 0.5               | -   | 10          | μΑ    |
|  | I <sub>OZL</sub> | GND  |                     | Max                 | -                                     | -0.5              | -   | -10         | μΑ    |
| Input Clamp Voltage  | V <sub>IK</sub>  | V <sub>CC</sub> or<br>GND                        | -18                 | Min                 | -                                     | -1.2              | -   | -1.2        | V     |
| Short Circuit Output Current<br>(Note 3)   | I <sub>OS</sub>  | V <sub>CC</sub> = 0<br>V <sub>CC</sub> or<br>GND |                     | Мах                 | -60                                   | -                 | -60 | -           | mA    |
| Quiescent Supply Current, MSI  | ICC              | V <sub>CC</sub> or<br>GND                        | 0                   | Max                 | -                                     | 8                 | -   | 80          | μA    |
| Additional Quiescent Supply<br>Current per Input Pin<br>TTL Inputs High, 1 Unit Load | Δl <sub>CC</sub> | 3.4V<br>(Note 4)                                 |                     | MAX                 | -                                     | 1.6               | -   | 1.6         | mA    |

#### NOTES:

3. Not more than one output should be shorted at one time. Test duration should not exceed 100ms.

4. Inputs that are not measured are at  $V_{\mbox{CC}}$  or GND.

5. FCT Input Loading: All inputs are 1 unit load. Unit load is  $\Delta I_{CC}$  limit specified in Static Characteristics Chart, e.g., 1.6mA Max at 70°C.

|  |            |                                     |                     | AMBIEN            |                                       |      |       |
|--|------------|-------------------------------------|---------------------|-------------------|---------------------------------------|------|-------|
|  |            |                                     |                     | 25 <sup>0</sup> C | 0 <sup>о</sup> С ТО 70 <sup>о</sup> С |      | UNITS |
| PARAMETER  |            | SYMBOL                              | V <sub>CC</sub> (V) | ТҮР               | MIN                                   | MAX  |       |
| Propagation Delays   |            |                                     |                     |                   |                                       |      |       |
| Clock to Q   | CD74FCT574 | t <sub>PLH</sub> , t <sub>PHL</sub> | 5                   | 6.6               | 2                                     | 10   | ns    |
| Clock to $\overline{Q}$  | CD74FCT564 | tPLH, tPHL                          | 5                   | 6.6               | 1.5                                   | 10   | ns    |
| Output Disable to Q  | CD74FCT574 | t <sub>PLZ</sub> , t <sub>PHZ</sub> | 5                   | 6                 | 1.5                                   | 8    | ns    |
| Output Enable to Q   | CD74FCT574 | t <sub>PZL</sub> , t <sub>PZH</sub> | 5                   | 9                 | 1.5                                   | 12.5 | ns    |
| Output Disable to $\overline{Q}$   | CD74FCT564 | t <sub>PLZ</sub> , t <sub>PHZ</sub> | 5                   | 6                 | 1.5                                   | 8    | ns    |
| Output Enable to $\overline{Q}$  | CD74FCT564 | t <sub>PZL</sub> , t <sub>PZH</sub> | 5                   | 9                 | 1.5                                   | 12.5 | ns    |
| Power Dissipation Capacitance  |            | C <sub>PD</sub><br>(Note 6)         | -                   |                   | 34 Typical                            |      | pF    |
| Minimum (Valley) V <sub>OHV</sub> During Switching of<br>Other Outputs (Output Under Test Not Switching) |            | V <sub>OHV</sub><br>(Figure 1)      | 5                   | 0.5               | -                                     | -    | V     |
| Maximum (Peak) V <sub>OLP</sub> During Switching of<br>Other Outputs (Output Under Test Not Switching)   |            | V <sub>OLP</sub><br>(Figure 1)      | 5                   | 1                 | -                                     | -    | V     |
| Input Capacitance  |            | Cl                                  | -                   | -                 | -                                     | 10   | pF    |
| Three State Output Capacitance   |            | С <sub>О</sub>                      | -                   | -                 | -                                     | 15   | pF    |

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NOTE:

6. C<sub>PD</sub>, measured per flip-flop, is used to determine the dynamic power consumption. PD (per package) =  $V_{CC} I_{CC} + \Sigma (V_{CC}^2 f_I C_{PD} + V_O^2 \text{ to } C_L + V_{CC} \Delta I_{CC} D)$  where:  $V_{CC}$  = supply voltage  $\Delta I_{CC}$  = flow through current x unit load  $C_L$  = output load capacitance D = duty cycle of input high fo = output frequency

 $f_{O}$  = output frequency

 $f_{I} = input frequency$ 

#### **Prerequisite For Switching**

|                          |                  |                     | AMBIENT TEMPERATURE (T <sub>A</sub> ) |             |     |       |  |
|--------------------------|------------------|---------------------|---------------------------------------|-------------|-----|-------|--|
|                          |                  |                     | 25 <sup>0</sup> C                     | 0°C TO 70°C |     | ]     |  |
| PARAMETER                | SYMBOL           | V <sub>CC</sub> (V) | ТҮР                                   | MIN         | MAX | UNITS |  |
| Clock Pulse Width        |                  |                     |                                       |             |     |       |  |
| CD74FCT574               | t <sub>W</sub>   | 5 (Note 7)          |                                       | 7           | -   | ns    |  |
| CD74FCT564               | t <sub>W</sub>   | 5                   |                                       | 7           | -   | ns    |  |
| Setup Time Data to Clock | ts∪              | 5                   |                                       | 2           | -   | ns    |  |
| Data to Clock Hold Time  |                  |                     |                                       |             |     |       |  |
| CD74FCT574               | t <sub>H</sub>   | 5                   |                                       | 2           | -   | ns    |  |
| CD74FCT564               | t <sub>H</sub>   | 5                   |                                       | 2           | -   | ns    |  |
| Maximum Clock Frequency  | f <sub>MAX</sub> | 5                   |                                       | 70          | -   | MHz   |  |

NOTE:

7. 5V: minimum is at 4.5V.

5V: minimum is at 4.75V for  $0^{\circ}$ C to  $70^{\circ}$ C.

Typical is at 5V.

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